

# **Notice of References Cited**

Application/Control No.

10/023,636

Applicant(s)/Patent Under Reexam

Furman et al

Examiner

R.S. Travers J.D., Ph.D.

Art Unit

1617

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
x	A	3,798,209	3/1974	Witkowski et al	260	211.5
x	B	5,270,315	12/1993	Belleau et al	514	262
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	M					

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
	N						
	O						
	P						
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	R						
	S						
	T						

## **NON-PATENT DOCUMENTS**

*		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
	U	Ichimura et al, 123CA:160186, 1995
	V	<i>Fernando-Larsson et al 114 CA:55350 1990</i>
	W	
	X	

\* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.